

Checking pipelined disributed global properties for post-silicon debug

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Checking Pipelined Distributed Global Properties for Post-silicon Debug

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Abstract—

While multi-processor system-on-chips (MPSOCs) with network-on-chip (NOC) interconnect are becoming increasingly common to meet the constant performance demand, it is due to communication delays in the NOC extremely complicated to ensure that software executes correctly. In this paper, we extend our architecture that non-intrusively observes global properties at run time using distributed monitors such that not only single tokens but also pipelined tokens can be monitored. We detail the solution for a given race and compare the alternatives of having one large monitor versus multiple small monitors.

Index Terms—Validation, races, monitors, distributed property checking

I. INTRODUCTION

The increasing demand for performance is addressed using multi-processor system-on-chips (MPSOCs), which consist of a number of processors and supporting peripherals, with network-on-chip (NOC) interconnects, combined in a single integrated circuit (IC). While NOC-based MPSOCs meet the performance demand, it is hard to ensure that an MPSOC meets its specification due to its hardware and software complexity.

Pre-silicon verification of software and hardware does not imply that the complete (final) system meets its specification because execution models may not match, and fault models may not capture all failures. As a result post-silicon debug is often required to find out why the final physical system does not work as expected. Post-silicon debug of an MPSOC is a challenge because an MPSOC typically contains a number of unsynchronized clock domains. Global properties about the system therefore require communication between multiple distributed units in different domains (possibly far apart) with non-negligible communication delays. There are several problems to overcome. First, there is a need to be able to monitor local properties, preferably in a non-intrusive way such that the functional operation is not impacted. Second, results of local distributed monitors must be combined for global properties. Sending information over the functional interconnect may impact functional performance and/or end product cost and is therefore not desirable. Adding extensive additional infrastructure for post-silicon debug is also costly. Third, there is no common time reference in the system due to the use of multiple clock domains, which complicates creating a globally consistent view on the system [1]. Fourth, the fact

that local properties may become true millions of clock cycles apart from each other requires efficient handling and analysis of large data volumes.

We have previously developed an architecture to monitor for communication delays in NOC-based MPSOCs [2]. In particular, we showed the ability to check for races where *one* token consisting of a number of words is produced and consumed correctly. However, in general, *multiple* tokens can be pipelined. A producer can generate an arbitrary number of tokens and it can be very difficult to detect which specific word(s) cause(s) the problem. The fundamental problem is to distinguish and associate reads and writes in the memory with tokens. Hence, there is a need to check pipelined tokens. Based on our work [2], we detail the two alternatives: 1 N-token monitor and N 1-token monitors. We made a case study where we detail the overhead of each approach.

The paper is organized as follows. Related work is in Section II and a high-level overview is in Section III. Races are described in Section IV, our distributed debug architecture in Section V. A case study where we find races at run time is given in Section VI. We conclude with Section VII.

II. RELATED WORK

Observing the state of the system is very difficult due to the limited access to the state of the internal nodes (e.g. flip-flops). A straight-forward approach to observe the system's state is to reuse the scan-chains, which are present to enable manufacturing test. Scan-chains, flip-flops with additional multiplexers, are commonly used to apply manufacturing tests. The scan-chains allow to capture the state of the system at a given time [3]. While it is cost-effective to reuse the scan-chains, as they are already present for manufacturing test, their use is intrusive, as the system must be stopped while the content of the flip-flops is serially shifted out. It also only allows a single snap-shot to be taken of the system at a time after the MPSOC has been stopped. Stopping the clocks for a globally consistent snap-shot is difficult due to the multiple clock domains [4], [5]. After taking the snap-shot, the system execution has to be resumed or restarted. Resuming the execution of the system to make additional snap-shots is also difficult, as the precise clock relations among the internal clock domains, and the synchronization with the external environment at the moment of stopping may not be restorable.

A non-intrusive debug approach is to make use of trace buffers, which is common in today’s processors [6]. However, the constant increase of complexity and circuit speeds enforce larger trace buffers, and techniques to compress data have been developed [7]. In MPSOCs, there is even a need for multiple trace buffers, monitors to trigger on events, and communication between monitors. An MPSOC debug architecture with a separate interconnect for debug is proposed in [8]. In a similar set-up, re-use of the functional interconnect is proposed to send debug data [9], or synchronization tokens [10]. The functional application is impacted by this debug activity, which is not desirable.

While a significant number of works have been proposed on silicon debug, no work but our previous work [2] details races that cannot be envisioned at the software level, or demonstrates how to detect these races. Different from our previous work ([2]) where a single token of a number of words is considered, we address in this paper multiple pipelined tokens.

III. HIGH-LEVEL OVERVIEW

Figure 1 shows a task graph that consists of nodes and directed edges where a node represents a computation task and an edge between nodes represents communication between tasks. Figure 2 shows the task graph in Figure 1 mapped on an example MPSOC. Task T_0 receives and distributes inputs to task T_1 , executing on CPU_0 , and task T_3 , executing on CPU_0 . Tasks T_2 is executed on CPU_0 together with Task T_1 , while T_4 is executed on CPU_2 together with Task T_3 . Given the results of task T_2 and T_4 , task T_5 produces the outputs of the MPSOC.

The communication between tasks, represented by edges between the tasks, can be implemented by First-In First-Out (FIFO) queues. A FIFO queue can be hardware-based, i.e. implemented with dedicated hardware, or software-based, i.e. assigning a part of the shared memory for the FIFO. In this paper, we assume that the FIFO queues are implemented as parts of the shared memory between CPU_0 and CPU_1 .

A software-based FIFO is often implemented as a circular buffer. The advantage with this implementation is that only pointers and not elements have to be updated when operating on the FIFO. Figure 3 details a circular FIFO on which two tasks (a producer and a consumer) operate and the four associated pointers, $FIFO_{top}$, $FIFO_{bottom}$, RD_{ptr} , and WR_{ptr} . The pointers $FIFO_{top}$ and $FIFO_{bottom}$ define the size of the FIFO and the pointer RD_{ptr} defines where to read from the FIFO at a given point in time and WR_{ptr} defines where to write to the FIFO at a given point in time. The valid data of the FIFO is always between RD_{ptr} and the WR_{ptr} ; however, as the pointers are constantly updated based on FIFO reads and writes, the valid area changes. The pointers RD_{ptr} and WR_{ptr} always have to be between $FIFO_{top}$ and $FIFO_{bottom}$. However, even then two alternatives exist for the valid area; alternative one - the case where RD_{ptr} is larger than WR_{ptr} , and alternative two - the case where WR_{ptr} has passed $FIFO_{top}$ and restarted at $FIFO_{bottom}$, and is

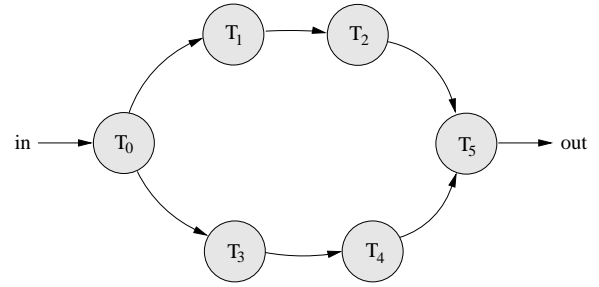


Fig. 1. A task graph

smaller than RD_{ptr} . As soon as RD_{ptr} also passes $FIFO_{top}$ and restarts at $FIFO_{bottom}$, alternative one is valid again.

In order to minimize the memory latency and traffic in the NOC, it is common practice that pointers are kept locally at the producer and consumer. The $FIFO_{top}$ and $FIFO_{bottom}$ pointers are static and are not changed during the application and therefore copies can be kept locally at the consumer and the producer to ensure pointer consistency. However, the RD_{ptr} and the WR_{ptr} are constantly updated during application. The general scheme is that the producer keeps WR_{ptr} and a copy or RD_{ptr} (named RD'_{ptr}) while the consumer keeps RD_{ptr} and a copy of WR_{ptr} (named WR'_{ptr}).

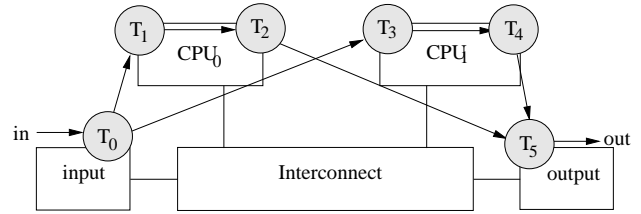


Fig. 2. A task graph mapped on a system

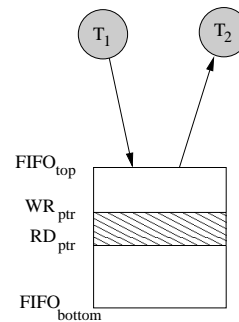


Fig. 3. Detailing two tasks (consumer and producer) operating on a FIFO

Figure 4 shows two communicating tasks, T_1 and T_2 , where the producer task T_1 generates elements that are used by the consumer task T_2 . In Figure 4, Task T_1 is mapped to CPU_1 while Task T_2 is mapped on CPU_2 .

Before writing to or reading from the FIFO the producer and consumer poll the read and write pointers. Figure 4 shows that the pointers WR_{ptr} and RD_{ptr} are kept in an on-chip memory which is accessible with a low latency, while the (usually much

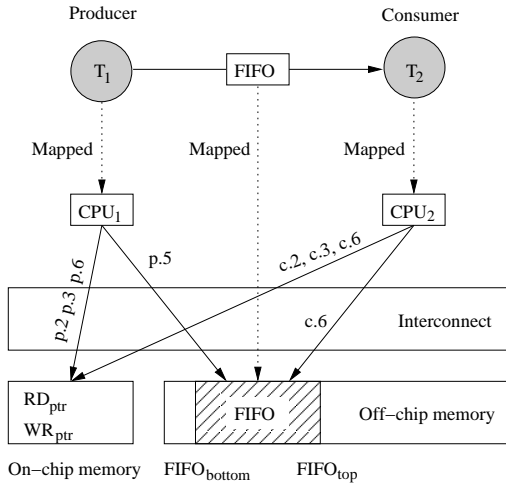


Fig. 4. A task graph and an example mapping

larger) FIFO data is kept in the large, slower off-chip memory.

The producer repeatedly enters new tokens into the FIFO by the transactions, as detailed in Figure 5, while the consumer repeatedly requests tokens from the FIFO by the transactions, as detailed in Figure 6. Figure 4 shows that the transactions $p.2, p.3, p.6$ operate on the on-chip memory while $p.5$ operates on the off-chip memory, and that the transactions $c.2, c.3, c.6$ operate on the on-chip memory while $c.5$ operates on the off-chip memory. The transactions by the producer and the consumer in Figure 4 over time are shown in Figure 7, using time lines of [11]. The producer, consumer, on-chip memory, and off-chip memory each have a time line indicating when transactions are issued and when they take effect. The example trace shows how both producer and consumer poll and check the pointers, followed by the successful transfer of one token.

(p.1)while (true)	(c.1)while (true)
(p.2) read RDptr	(c.2) read RDptr
(p.3) read WRptr	(c.3) read WRptr
(p.4) if ok_to_write	(c.4) if ok_to_read
(p.5) write data	(c.5) read data
(p.6) write WRptr	(c.6) write RDptr

Fig. 5. Producer side

Fig. 6. Consumer side

IV. RACES AND DISTRIBUTED CONDITIONS

Modern high-performance on-chip interconnects, such as multi-layer busses and networks on chip (NOC), are pipelined and concurrent, to serve many transactions at the same time. As a result, there is no single sequential system trace, as was the case for older, sequential interconnects. Distributed memories, effects in the NOC such as different path lengths, congestion, differential Quality-of-Service guarantees, as well as slave arbitration and different slave speeds of execution, make it often hard to predict when transactions are delivered and executed. As a result, read and write transactions issued in a given order by a processor may execute in a different order at

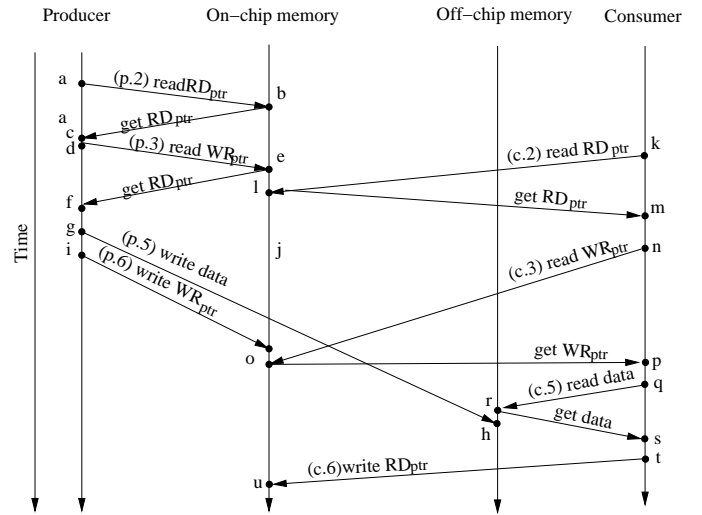


Fig. 7. Time diagram for producer and consumer

different slaves. Next, we illustrate how communication races may occur, using a NOC [12].

Figure 8 shows an execution trace of the transactions for the example of Figure 4 that although *issued in a valid order* may lead to an *incorrect execution*. The problem is that the update of WR_{ptr} ($p.6$) issued at i is quickly transported to and written in the on-chip memory at j . Hence, it can overtake the slower $write\ data$ ($p.5$), which is issued at g and written in the off-chip memory at h . The consumer reads the updated pointer WR_{ptr} ($c.3$) at o , but subsequently still reads old data ($read\ data\ c.5$) at r . To detect this race, which is a global property, it is required to monitor properties at the on-chip memory, and off-chip memory, and then correlate these distributed local properties to detect the race. A race similar to WR_{ptr} can occur for RD_{ptr} .

Figure 9 details reads and writes in terms of tokens where a token consists of a number of words. In our previous work ([2]) we solved the problem when writing and reading single tokens at a time. However, pipelined tokens remained unsolved. Before addressing how to detect possible races for pipelined tokens, we shortly revisit the supportive debug architecture.

V. DISTRIBUTED DEBUG ARCHITECTURE

Figure 10 shows a high-level overview of an MPSOC, including the NOC and IP blocks like processors, memory, etc., that are connected to a local bus using its arbiter (A) and to a network protocol shell (S). This shell translates a specific bus protocol to a stream of data words. These data words are then transported by the NOC from network interface (NI) to NI, using intermediate routers [12].

Figure 10 also shows the Event Distribution Interconnection (EDI) [4] (shaded), which is routed parallel to, but is independent from, the functional router network. Since the EDI broadcasts events, it is simpler, faster, and cheaper than the NOC. Extending our previous EDI implementations, it contains multiple planes, to allow for multiple events and

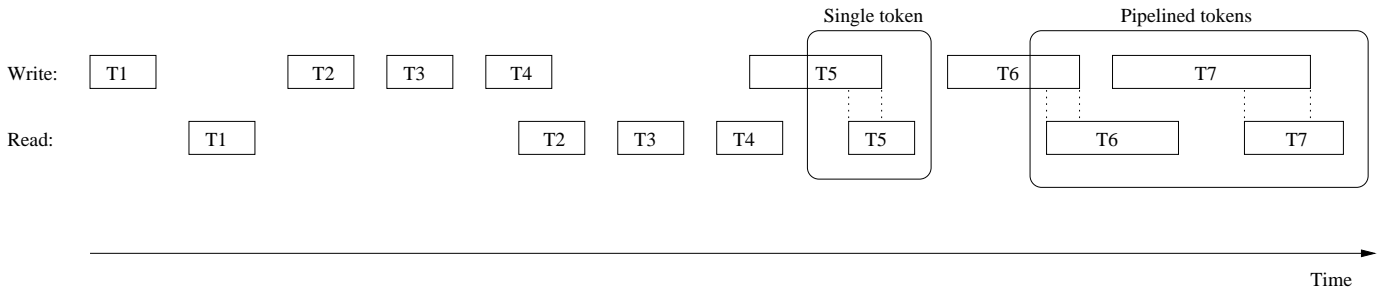


Fig. 9. Detailing single token and pipelined tokens

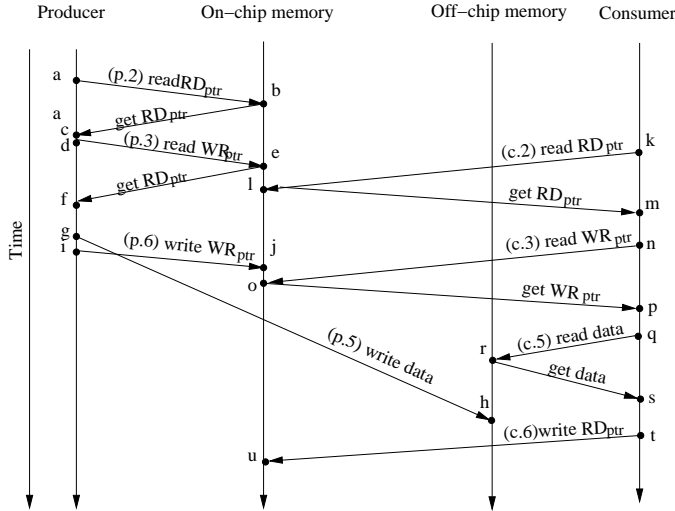


Fig. 8. Time diagram of a race

identification of the event's originator. The EDI delivers events to monitors, protocol-specific instruments (PSI) [13], or IP blocks, who can be programmed to either use, e.g. to stop communication and/or computation, or ignore them.

The monitor is non-intrusive as it only observes the bus to which it is attached and the events from other monitors that arrive over the EDI. Likewise, the outputs from the monitor are sent to other monitors using the EDI. A key advantage of the EDI is that all communication (and delays) are deterministic and fixed in time.

The monitor, shown in Figure 11, consists of a *bus reader*, three *data matchers (DMs)*, and a *state machine (SM)*. The bus reader is specific to the bus protocol, and forms the interface between the bus and the monitor. The bus reader takes the inputs from the bus and extracts address (*adr*), data (*write_data* and *read_data*), along with valid signals for each (*adr_valid*, *write_valid*, *read_valid*), and command information (*cmd*). The *cmd* from the bus reader is pipelined and turned into a signal *c* indicating a read or write operation. Outputs from the bus reader is fed to three programmable data matchers, which produces three outputs, *a*, *w*, *r*, respectively. Each of these three data matchers consists of two symmetric parts, left and right (refer to Figure 12). The low (high) register can be initialized to a pre-defined value or set during execution

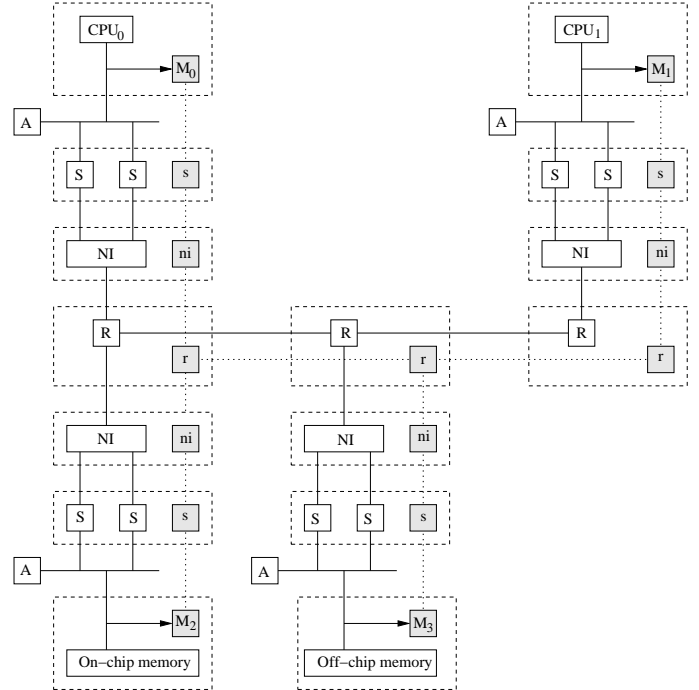


Fig. 10. A NOC with monitors and EDI for debug

to the input data. The low and high registers can independently be updated to an input value or to an incremented value. The low and high register can be masked such that a set of bits are ignored. The masked outcome is compared against the input (data), which also can be masked. A data matcher can check:

- 1) if (part of) its input is (not) equal, less or greater than a given value or the previous input, or
- 2) if (part of) its input is in a static or moving range [*min*, *max*].

The outputs of the three programmable data matchers (*a*, *w*, *r*) and the read or write command signal (*c*) are fed to a programmable state machine.

The state machine (Figure 13) is RAM-based to allow full programmability. The RAM input (*A* - address) is given by *events*, EDI_{in} and the *current state (CS)/ next state (NS)*. The RAM output (*D* - data) consists of EDI_{out} and the *current state (CS)/ next state (NS)*.

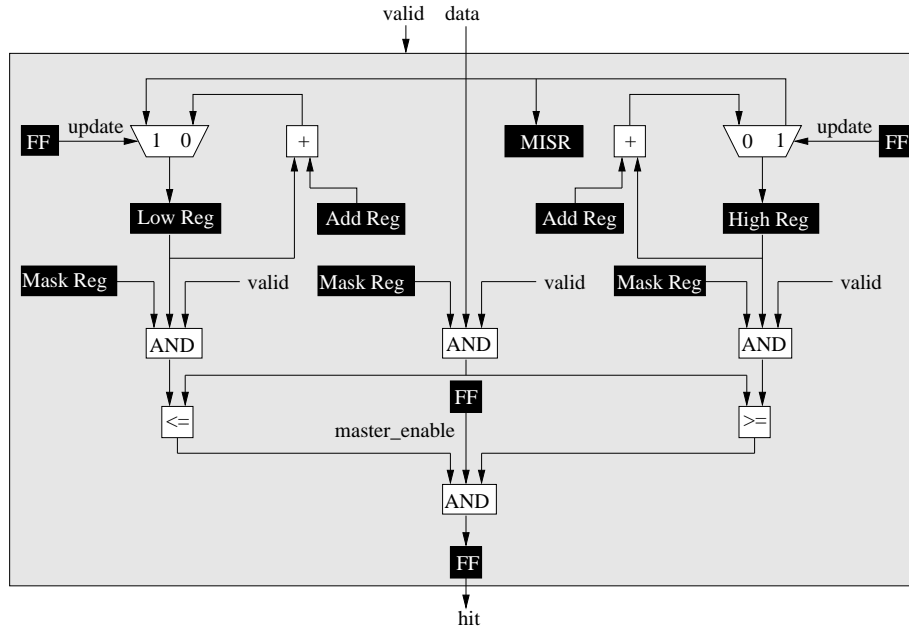


Fig. 12. One of three data matchers

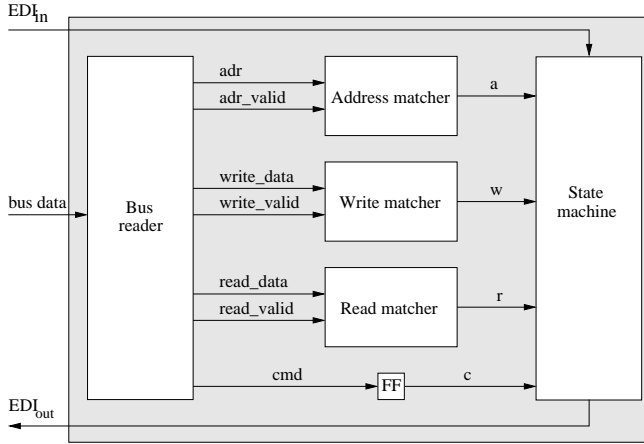


Fig. 11. Overview of the monitor

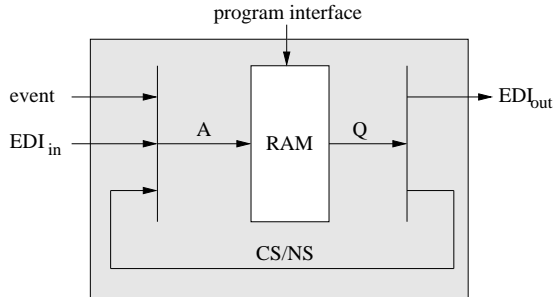


Fig. 13. State machine

VI. MONITORING PIPELINED TOKENS

We compare below the alternative of having one N -token monitor, capable of handling N tokens simultaneously, against N 1-token monitors, each capable of handling one token, but communication among each other via the EDI to also be able to handle N tokens simultaneously. We assume below a token size of 8 words. However, the approach applies to any token size.

Each monitor consists of three data matchers and a state machine implemented in RAM. The N -token monitor requires a larger state machine (RAM) to capture all states but reuse its data matchers and less additional EDI signaling between monitors. We compare RAM sizes, number of EDI signals, and number of data matchers.

- N 1-token monitors

In the case of N 1-token monitors, naturally N monitors are needed. The total size of the RAM (R) in bits (refer to Figure 13) depends on the number of *address bits* (a) and the *data word size* (d), and is given by $R = d \cdot 2^a$. The number of state bits (s) in an 1-token monitor is 6 (as derived in [2]). In addition, each of the N 1-token monitors uses a single EDI input to receive events from monitor M_2 , located at the on-chip control memory, three event inputs from the local data matchers (refer to Figure 11), an additional input to distinguish a read operation from a write operation, and three EDI inputs (and outputs) for inter monitor signaling. This brings the total number of address bits a to $s + 1 + 3 + 1 + 3 = 6 + 8 = 14$. On the RAM output side, two error signals and three inter monitor EDI signals result in $d = s + 2 + 3 = 6 + 5 = 11$. The total memory size is therefore given by $R_N = N \cdot 11 \cdot 2^{14}$ for the

use case with N 1-token monitors. For the corresponding EDI architecture, there is one EDI layer to receive events from monitor M_2 , and per monitor two layers for error signaling and three layers for inter monitor signaling, hence the total number of EDI layers equals $5 \cdot N + 1$. In addition, N 1-token monitors require three data matchers in each monitor, so $3 \cdot N$ in total.

- *1 N-token monitor*

A N -token monitor capable of handling N pipelined tokens needs 8 states to record the writing of the eight words of the first token. For subsequent pipelined tokens, reads of the previous token(s) and writes of the current token can arrive interchanged, hence, each pipeline stage plus the final stage connecting with the initial state requires $8 \cdot 8$ states. The total number of states is therefore given by $8 + 64 \cdot N$ for $N \geq 2$. The monitor has to be able to record up to N EDI events from monitor M_2 for N tokens (including zero). Hence, $\lceil \log_2[N + 1] \rceil$ bits are needed for EDI administration. The total number of state bits is given by: $s = \lceil \log_2(N + 1) \rceil \cdot (8 + 64 \cdot N)$. The monitor needs one EDI input to receive events from monitor M_2 , two outputs for error signaling and two inputs and outputs for inter monitor signaling, which leads to $d = s + 5$. The number of inputs $a = s + 2 \cdot N$ where $2 \cdot N$ is needed to distinguish a protocol violation from a network delay problem for each token. The total number of memory bits is: $(s + 2 \cdot N) \cdot 2^{(s+5)}$. For the EDI architecture, there is one EDI from monitor M_2 and two per monitor for error signaling, hence: $1 + 2 \cdot N$. Using a single monitor leads to three required data matchers.

In Figure 14, the resulting silicon area estimates of one N -token monitor and N 1-token monitors are reported for N ranging from 1 to 8. For $1 < N < 4$ the N -token monitor is more cost effective; however, at higher N , the N 1-token monitors become more effective mainly because the higher number of required states increases the RAM rapidly for the N -token monitor.

Overall, we prefer the implementation of N individual monitors over one single monitor, because the individual monitors will be more adaptable to other debug use cases as well.

VII. CONCLUSIONS

Software running on multi-processor system-on-chips with an advanced interconnect, such as a network-on-chip, may suffer from races that are difficult to detect. In this paper we extended our architecture to non-intrusively monitor for races, such that not only single tokens of a given number of words, but also pipelined token violations can be detected. The violations can be classified as timing errors or FIFO protocol violations. We have compared two implementation alternatives; 1 N -token monitor and N 1-token monitors.

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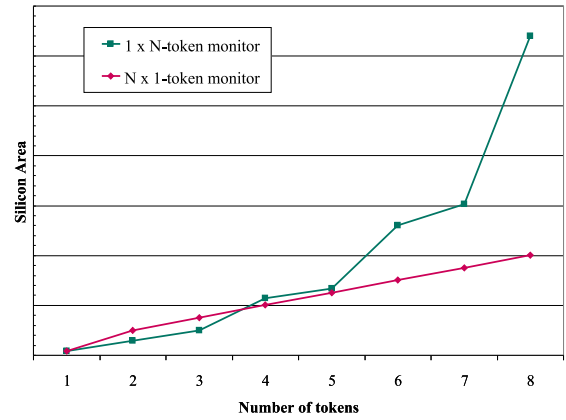


Fig. 14. Comparing area of $1 \times N$ -token monitor and $N \times 1$ -token monitors

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